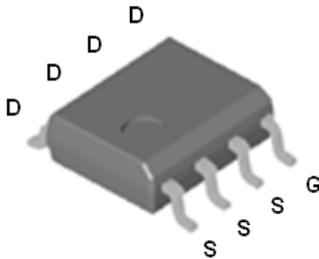


# PB210BV

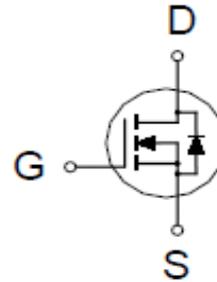
## N-Channel Enhancement Mode MOSFET

### PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
100V	230mΩ @ $V_{GS} = 10V$	2.1A



SOP-8



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ °C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS	
Drain-Source Voltage	$V_{DS}$	100	V	
Gate-Source Voltage	$V_{GS}$	±20		
Continuous Drain Current <sup>1</sup>	$I_D$	$T_A = 25\text{ °C}$	2.1	A
		$T_A = 70\text{ °C}$	1.7	
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	17		
Avalanche Current	$I_{AS}$	17		
Avalanche Energy	$L = 0.1\text{mH}$	$E_{AS}$	15.4	mJ
Power Dissipation	$P_D$	$T_A = 25\text{ °C}$	2.3	W
		$T_A = 70\text{ °C}$	1.5	
Junction & Storage Temperature Range	$T_j, T_{stg}$	-55 to 150	°C	

### THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient	$R_{\theta JA}$		50	°C / W
Junction-to-Case	$R_{\theta Jc}$		25	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Limited by Package.

## PB210BV

### N-Channel Enhancement Mode MOSFET

#### ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, Unless Otherwise Noted)

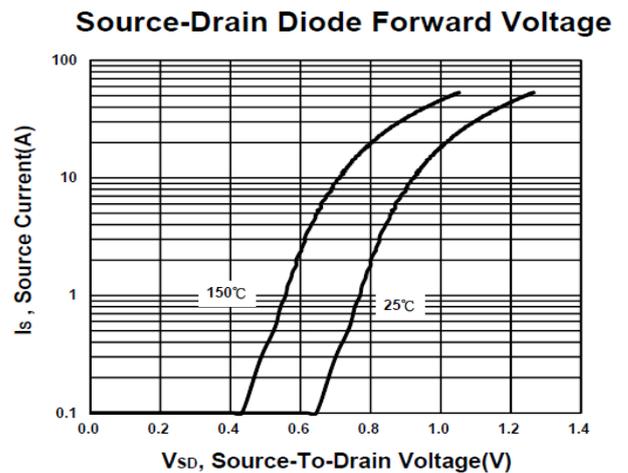
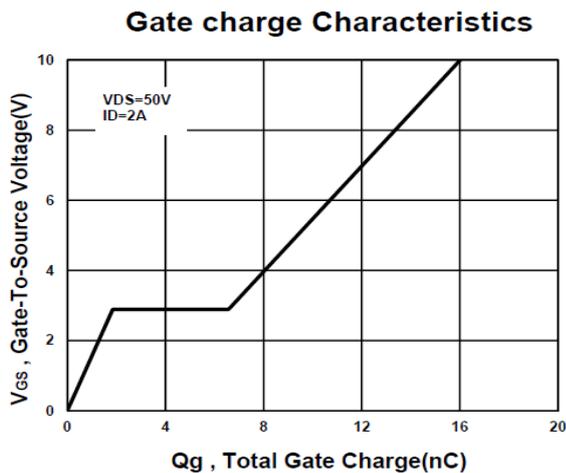
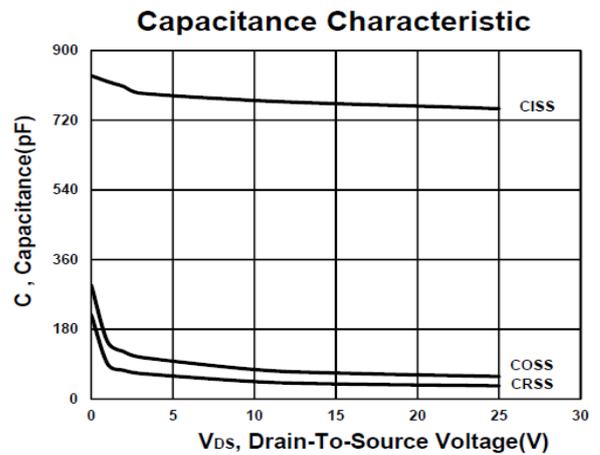
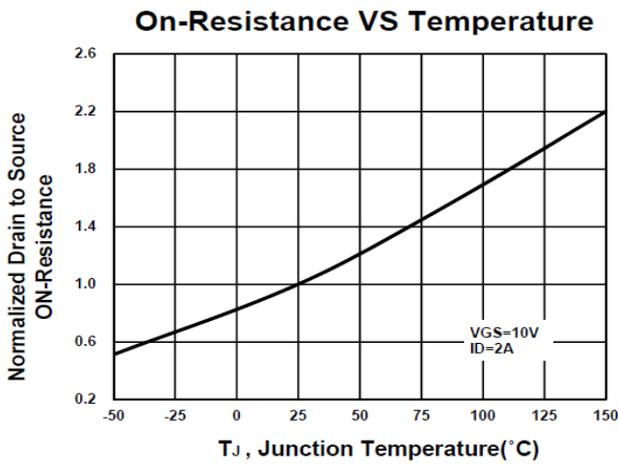
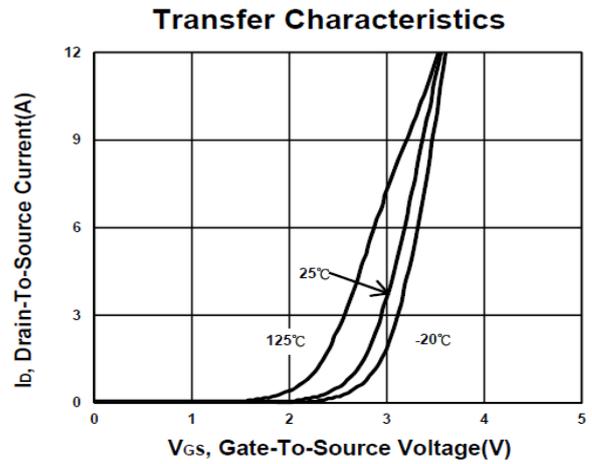
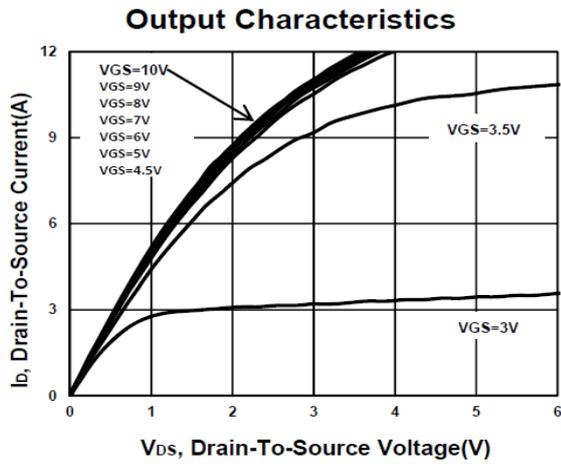
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	100			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1	1.5	2	V
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V			1	μA
		V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55 °C			10	
Drain-Source On-State Resistance <sup>1</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 5V, I <sub>D</sub> = 1A		189	240	mΩ
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 2A		182	230	
Forward Transconductance <sup>1</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 2A		8		S
<b>DYNAMIC</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1MHz		765		pF
Output Capacitance	C <sub>oss</sub>			59		
Reverse Transfer Capacitance	C <sub>rss</sub>			33		
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V, f = 1MHz		1.85		Ω
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	V <sub>DS</sub> = 50V, I <sub>D</sub> = 2A, V <sub>GS</sub> = 10V		16.1		nC
Gate-Source Charge <sup>2</sup>	Q <sub>gs</sub>			1.9		
Gate-Drain Charge <sup>2</sup>	Q <sub>gd</sub>			5		
Turn-On Delay Time <sup>2</sup>	t <sub>d(on)</sub>	V <sub>DS</sub> = 50V, I <sub>D</sub> ≅ 2A, V <sub>GS</sub> = 10V, R <sub>GEN</sub> = 6Ω		10		nS
Rise Time <sup>2</sup>	t <sub>r</sub>			12		
Turn-Off Delay Time <sup>2</sup>	t <sub>d(off)</sub>			15		
Fall Time <sup>2</sup>	t <sub>f</sub>			15		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T<sub>A</sub> = 25 °C)</b>						
Continuous Current	I <sub>S</sub>				1.8	A
Forward Voltage <sup>1</sup>	V <sub>SD</sub>	I <sub>F</sub> = 2A, V <sub>GS</sub> = 0V			1.4	V
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 2A, dI/dt = 100A / μS		28.9		nS
Diode Reverse Recovery Charge	Q <sub>rr</sub>				29	

<sup>1</sup>Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

<sup>2</sup>Independent of operating temperature.

# PB210BV

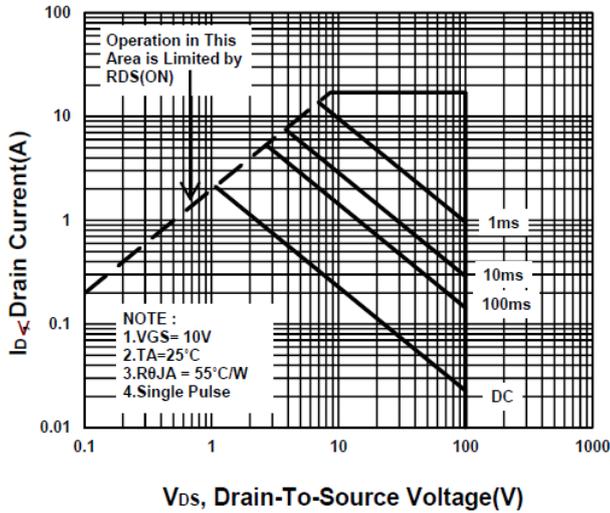
## N-Channel Enhancement Mode MOSFET



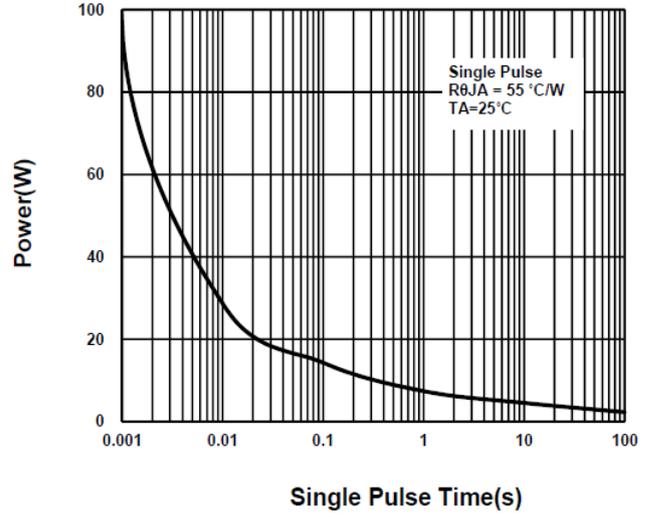
# PB210BV

## N-Channel Enhancement Mode MOSFET

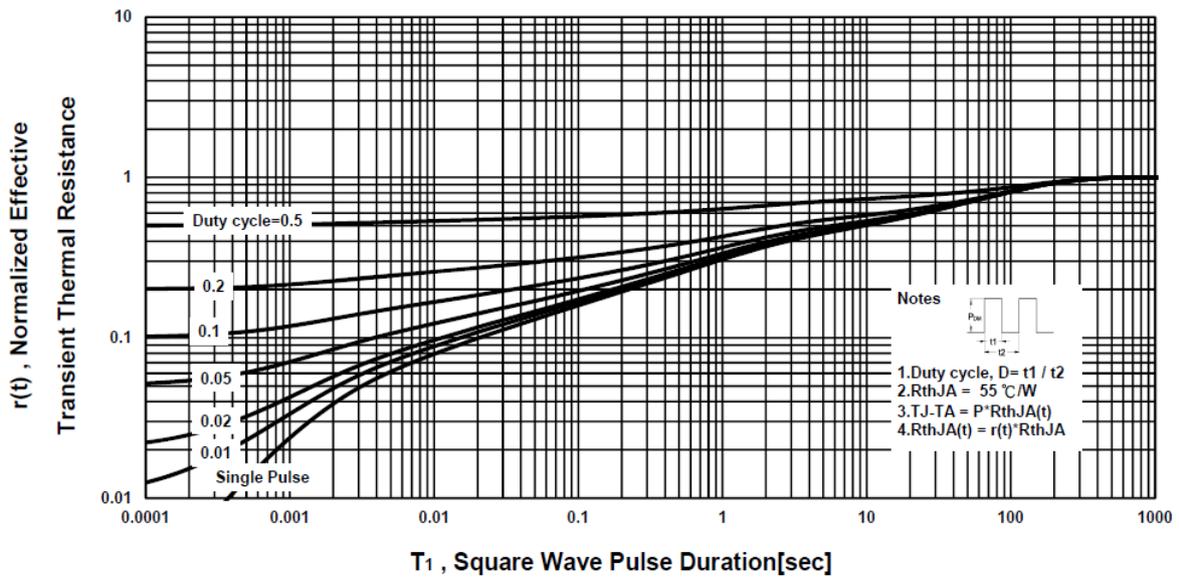
**Safe Operating Area**



**Single Pulse Maximum Power Dissipation**



**Transient Thermal Response Curve**



# PB210BV

## N-Channel Enhancement Mode MOSFET

### Package Dimension

### SOP-8 MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	4.8	4.9	5.0	H	0.4	0.6	0.93
B	3.8	3.9	4.0	I	0.19	0.21	0.25
C	5.79	6.0	6.2	J	0.25	0.375	0.5
D	0.33	0.4	0.51	K	0°	3°	18°
E	1.25	1.27	1.29				
F	1.1	1.3	1.65				
G	0.05	0.15	0.25				

